Application/Control No. Applicant(s)/Patent Under Reexamination 10/611,846 SCHMIDT ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Ahshik Kim 2876 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-6,415,982 B2 07-2002 Bridgelall et al. 235/472.01 US-2004/0016812 A1 01-2004 В Schmidt et al. 235/462.31 С US-D US-US-Ε F US-G US-US-Н US-1 US-J Κ US-L US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code **MM-YYYY** Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS**

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